

## **Search Notes**



**Application/Control No.**

10/542,322

**Examiner**

Bruck Kifle, Ph.D.

**Applicant(s)/Patent under  
Reexamination**

TOZAWA ET AL.

## **Art Unit**

1624

**SEARCHED**

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

## **SEARCH NOTES (INCLUDING SEARCH STRATEGY)**